



## HIGH SPEED DUAL CHANNEL OPTICALLY COUPLED ISOLATOR PHOTOTRANSISTOR OUTPUT

### APPROVALS

- UL recognised, File No. E91231

### DESCRIPTION

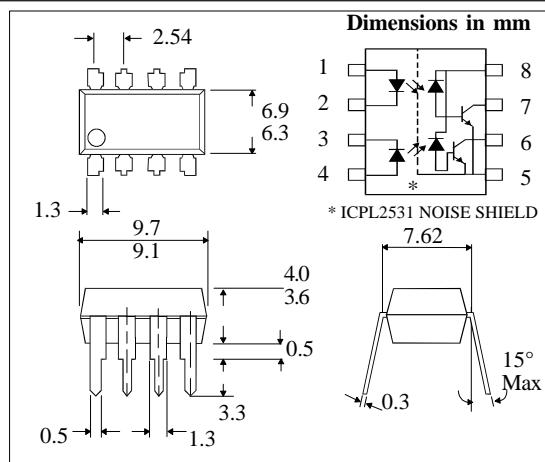
These dual channel diode-transistor optocouplers use a light emitting diode and an integrated photon detector to provide 2500Volts <sub>RMS</sub> electrical isolation between input and output. Separate connection for the photodiode bias and output transistor collector improve the speed up to a hundred times that of a conventional photo-transistor coupler by reducing the base-collector capacitance.

### FEATURES

- High speed - 250k b/s NRZ
- High Common Mode Transient Immunity 1000V/ $\mu$ s
- TTL Compatible
- Open Collector Outputs
- 2500V <sub>RMS</sub> Withstand Test Voltage, 1 Min
- Options :-  
10mm lead spread - add G after part no.  
Surface mount - add SM after part no.  
Tape&reel - add SMT&R after part no.
- All electrical parameters 100% tested
- Custom electrical selections available

### APPLICATIONS

- Line receivers
- Pulse transformer replacement
- Wide bandwidth analog coupling
- Output interface to CMOS-LSTTL-TTL

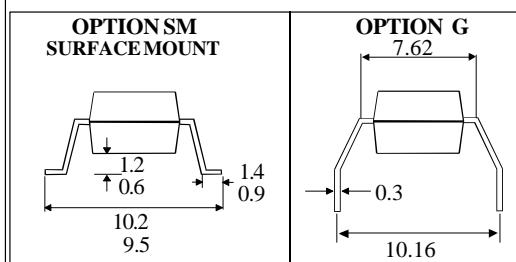


### ABSOLUTE MAXIMUM RATINGS (25°C unless otherwise specified)

Storage Temperature \_\_\_\_\_ -55°C to + 125°C  
Operating Temperature \_\_\_\_\_ -55°C to + 100°C  
Lead Soldering Temperature  
(1/16 inch (1.6mm) from case for 10 secs) 260°C

### INPUT DIODE

Average Forward Current \_\_\_\_\_ 25mA ( 1 )  
Peak Forward Current \_\_\_\_\_ 50mA ( 2 )  
( 50% duty cycle, 1ms pulse width )  
Peak Transient Current \_\_\_\_\_ 1.0A  
(equal to or less than 1 $\mu$ s P.W., 300 pps)  
Reverse Voltage \_\_\_\_\_ 5V  
Power Dissipation \_\_\_\_\_ 45mW( 3 )



### DETECTOR

Average Output Current \_\_\_\_\_ 8mA  
Peak Output Current \_\_\_\_\_ 16mA  
Supply Voltage \_\_\_\_\_ -0.5 to +30V  
Output Voltage \_\_\_\_\_ -0.5 to +20V  
Power Dissipation \_\_\_\_\_ 35mW( 4 )

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**ELECTRICAL CHARACTERISTICS (  $T_A = 0^\circ\text{C}$  to  $70^\circ\text{C}$  Unless otherwise noted )**

PARAMETER	SYM	DEVICE	MIN	TYP*	MAX	UNITS	TEST CONDITION
Current Transfer Ratio (note 5,6 )	CTR		15	21		%	$I_F = 8\text{mA}, V_o = 0.5\text{V}, V_{cc} = 4.5\text{V}, T_A = 25^\circ\text{C}$
			12	19		%	$I_F = 16\text{mA}, V_o = 0.5\text{V}, V_{cc} = 4.5\text{V}, T_A = 25^\circ\text{C}$
			11	14		%	$I_F = 8\text{mA}, V_o = 0.5\text{V}, V_{cc} = 4.5\text{V}$
			9	12		%	$I_F = 16\text{mA}, V_o = 0.5\text{V}, V_{cc} = 4.5\text{V}$
Logic Low Output Voltage (note 5 )	$V_{OL}$			0.2	0.5	V	$I_F = 8\text{mA}, I_o = 0.7\text{mA}, V_{cc} = 4.5\text{V}$
				0.2	0.5	V	$I_F = 16\text{mA}, I_o = 1.1\text{mA}, V_{cc} = 4.5\text{V}$
Logic High Output Current (note 5 )	$I_{OH}$			0.02	500	nA	$I_{F1} = I_{F2} = 0\text{mA}, T_A = 25^\circ\text{C}, V_{o1} = V_{o2} = V_{cc} = 5.5\text{V}$
					50	$\mu\text{A}$	$I_{F1} = I_{F2} = 0\text{mA}, V_{o1} = V_{o2} = V_{cc} = 15\text{V}$
Logic Low Supply Current	$I_{CCL}$			40		$\mu\text{A}$	$I_{F1} = I_{F2} = 8\text{mA}, V_{cc} = 5.5\text{V}, V_{o1} = V_{o2} = \text{open}$
				80		$\mu\text{A}$	$I_{F1} = I_{F2} = 16\text{mA}, V_{cc} = 5.5\text{V}, V_{o1} = V_{o2} = \text{open}$
Logic High Supply Current	$I_{CCH}$			0.05	4	$\mu\text{A}$	$I_{F1} = I_{F2} = 0\text{mA}, V_{cc} = 5.5\text{V}, V_{o1} = V_{o2} = \text{open}$
Input Forward Voltage (note 5 )	$V_F$			1.5	1.7	V	$I_F = 8\text{mA}, T_A = 25^\circ\text{C}$
				1.5	1.7	V	$I_F = 16\text{mA}, T_A = 25^\circ\text{C}$
Temperature Coefficient of Forward Voltage (note 5 )	$\frac{\Delta V_F}{\Delta T_A}$			-1.6		$\text{mV}/^\circ\text{C}$	$I_F = 8\text{mA}$
				-1.6		$\text{mV}/^\circ\text{C}$	$I_F = 16\text{mA}$
Input Reverse Voltage (note 5 )	$V_R$		5			V	$I_R = 10\mu\text{A}, T_A = 25^\circ\text{C}$
Input Capacitance (note 5 )	$C_{IN}$			60		pF	$f = 1\text{MHz}, V_F = 0$
Input-output Isolation Voltage (note 7)	$V_{ISO}$		2500	5000		$V_{RMS}$	R.H.equal to or less than 50%, $t = 1\text{min}, T_A = 25^\circ\text{C}$
Resistance (Input to Output)(note 7)	$R_{I-O}$			$10^{12}$		$\Omega$	$V = 500\text{V dc}$
Capacitance (Input to Output)(note7)	$C_{I-O}$					pF	$f = 1\text{MHz}$
	$I_{I-I}$					$\mu\text{A}$	45 % Relative Humidity $t = 5\text{s}, V = 500\text{V dc}$
Resistance (Input to Input)(note8)	R			$10^{11}$		$\Omega$	$V_{I-I} = 500\text{V dc}$
Capacitance (Input to Input)(note8)	$C_{I-I}$			0.25		pF	$f = 1\text{MHz}$

7/12/00 \*All typicals at  $T_A = 25^\circ\text{C}$

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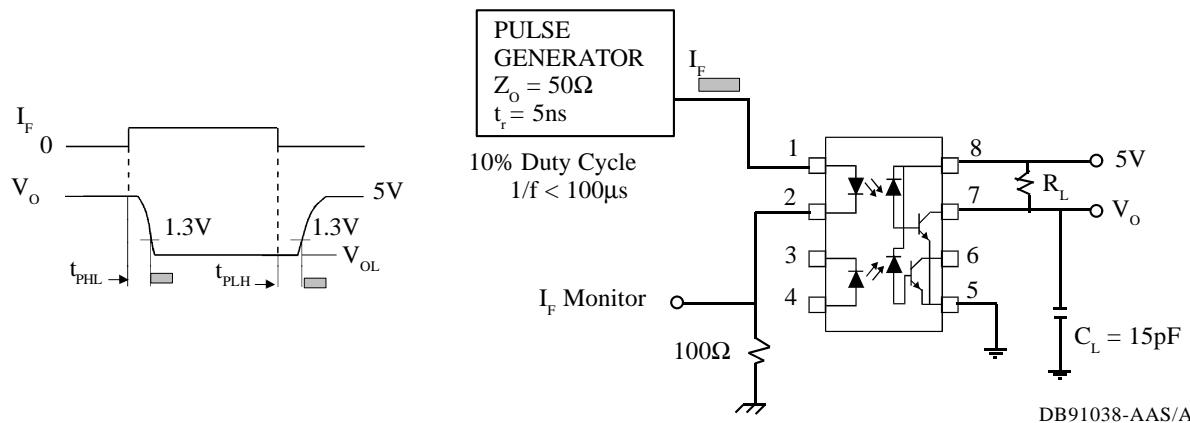
**SWITCHING SPECIFICATIONS AT  $T_A = 25^\circ\text{C}$  (  $V_{CC} = 5\text{V}$  Unless otherwise noted )**

PARAMETER	SYM	DEVICE	MIN	TYP	MAX	UNITS	TEST CONDITION
Propagation Delay Time to Logic Low at Output ( fig 1 )	$t_{PHL}$			0.8	1.5	$\mu\text{s}$	$I_F = 8\text{mA}, R_L = 7.5\text{k}\Omega$ (note 10)
				0.3	1.5	$\mu\text{s}$	$I_F = 16\text{mA}, R_L = 4.7\text{k}\Omega$ , (note 11)
Propagation Delay Time to Logic High at Output ( fig 1 )	$t_{PLH}$			1.0	2.5	$\mu\text{s}$	$I_F = 8\text{mA}, R_L = 7.5\text{k}\Omega$ , (note 10)
				1.1	2.5	$\mu\text{s}$	$I_F = 16\text{mA}, R_L = 4.7\text{k}\Omega$ , (note 11)
Common Mode Transient Immunity at Logic High Level Output ( fig 2 )	$CM_H$			1000		$\text{V}/\mu\text{s}$	$I_F = 0\text{mA}, V_{CM} = 10V_{PP}$ $R_L = 7.5\text{k}\Omega$ ,(note 9,10)
				1000		$\text{V}/\mu\text{s}$	$I_F = 0\text{mA}, V_{CM} = 10V_{PP}$ $R_L = 4.7\text{k}\Omega$ ,(note 9,11)
Common Mode Transient Immunity at Logic Low Level Output ( fig 2 )	$CM_L$			-1000		$\text{V}/\mu\text{s}$	$I_F = 8\text{mA}, V_{CM} = 10V_{PP}$ $R_L = 7.5\text{k}\Omega$ ,(note 9,10)
				-1000		$\text{V}/\mu\text{s}$	$I_F = 16\text{mA}, V_{CM} = 10V_{PP}$ $R_L = 1.9\text{k}\Omega$ ,(note 9,11)

**NOTES:-**

1. Derate linearly above  $70^\circ\text{C}$  free air temperature at a rate of  $0.8 \text{ mA}/^\circ\text{C}$ .
2. Derate linearly above  $70^\circ\text{C}$  free air temperature at a rate of  $1.6 \text{ mA}/^\circ\text{C}$ .
3. Derate linearly above  $70^\circ\text{C}$  free air temperature at a rate of  $0.9 \text{ mW}/^\circ\text{C}$ .
4. Derate linearly above  $70^\circ\text{C}$  free air temperature at a rate of  $1.0 \text{ mW}/^\circ\text{C}$ .
5. Each channel.
6. CURRENT TRANSFER RATIO is defined as the ratio of output collector current,  $I_O$ , to the forward LED input current,  $I_F$  times 100%.
7. Device considered a two-terminal device: pins 1,2,3, and 4 shorted together and pins 5,6,7, and 8 shorted together.
8. Measured between pins 1 and 2 shorted together, and pins 3 and 4 shorted together.
9. Common mode transient immunity in Logic High level is the maximum tolerable (positive)  $dV_{CM}/dt$  on the leading edge of the common mode pulse  $V_{CM}$  to assure that the output will remain in a Logic High state (i.e.  $V_O > 2.0\text{V}$ ). Common mode transient immunity in Logic Low level is the maximum tolerable (negative)  $dV_{CM}/dt$  on the trailing edge of the common mode pulse signal,  $V_{CM}$  to assure that the output will remain in Logic Low state (i.e.  $V_O < 0.8\text{V}$ ).
10. The  $7.5\text{k}\Omega$  load represents 1 LSTTL unit load of  $0.36\text{mA}$  and a  $20\text{k}\Omega$  pull-up resistor.
11. The  $4.7\text{k}\Omega$  load represents 1 LSTTL unit load of  $0.36\text{mA}$  and a  $8.2\text{k}\Omega$  pull-up resistor.
12. The  $2500 \text{ V}_{RMS}$  / 1 minute capability is validated by a factory  $3.1\text{k} \text{ V}_{RMS}$  / 1 second dielectric test.

**FIG.1 SWITCHING TEST CIRCUIT**



**FIG. 2 TEST CIRCUIT FOR TRANSIENT IMMUNITY AND TYPICAL WAVEFORMS**

